

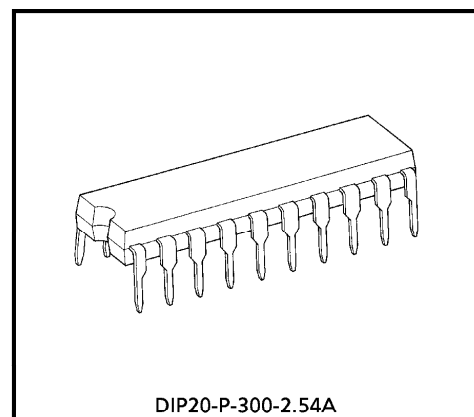
TOSHIBA Bi-CMOS INTEGRATED CIRCUIT SILICON MONOLITHIC

TD62C851P, TD62C852P**8BIT SERIAL-IN PARALLEL-OUT SHIFT REGISTER / LATCH DRIVERS**

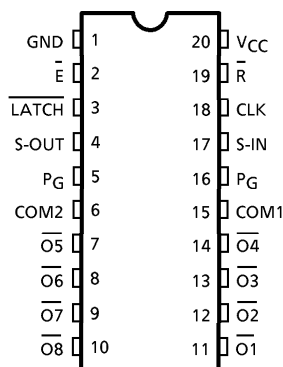
The TD62C851P and TD62C852P are monolithic circuits designed to be used together with Bi-CMOS integrated circuits. The devices consist of a 8bit shift register, 8bit latches, and 8 output circuits (integral clamp diodes for switching inductive loads).

FEATURES

- 8bit serial-in parallel-out shift register / latch driver (Bi-CMOS process)
- Output sustaining voltage ; 50V
- Output current ; TD62C851P 200mA / ch (Low saturation type)
TD62C852P 500mA / ch (darlington type)
- Built-in output clamp diodes
- CMOS compatible inputs
- Package ; DIP20-P-300A



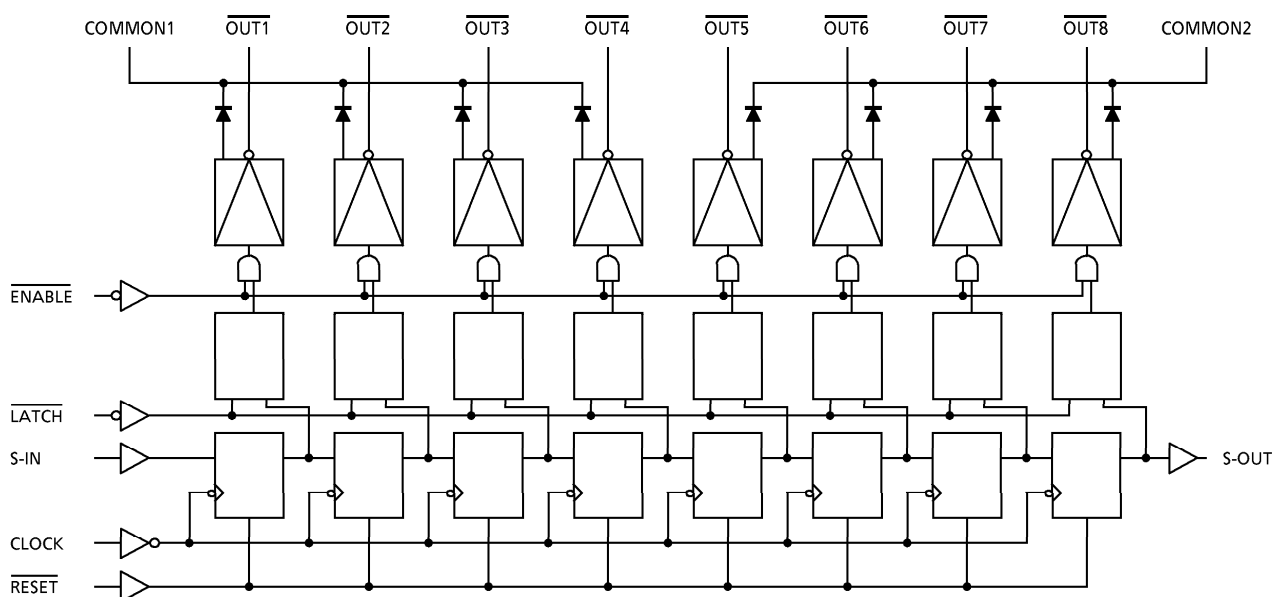
Weight : 2.25g (Typ.)

PIN CONNECTION (TOP VIEW)

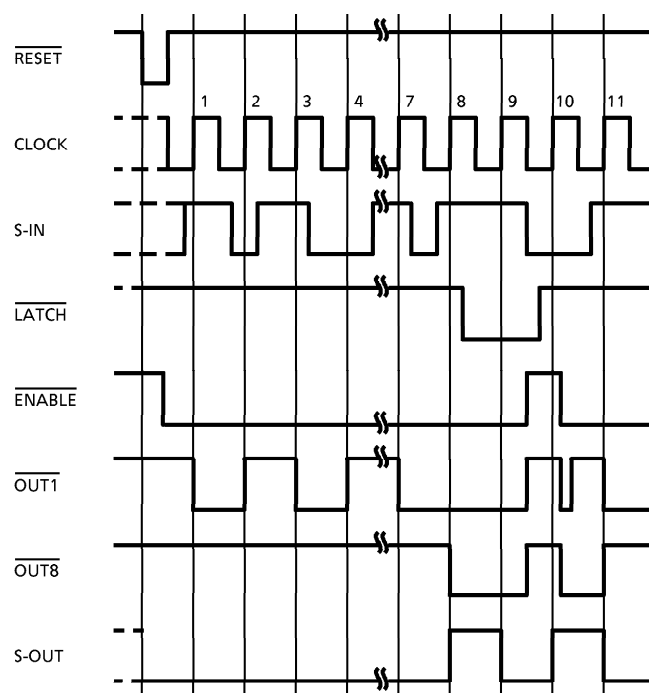
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BLOCK DIAGRAM

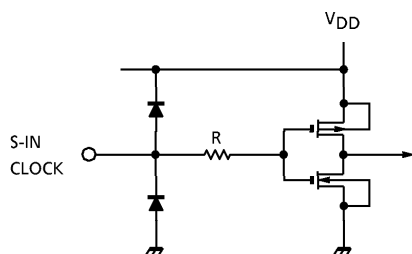


TIMING DIAGRAM

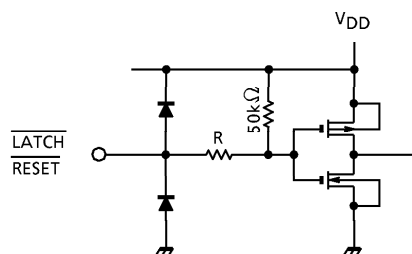


EQUIVALENT OF INPUTS AND OUTPUTS

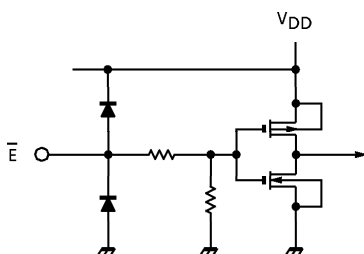
S-IN, clock terminal equivalent circuits



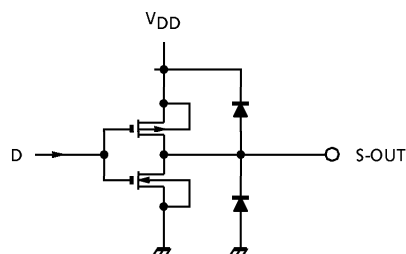
$\overline{\text{LATCH}}$, $\overline{\text{RESET}}$ terminal equivalent circuits



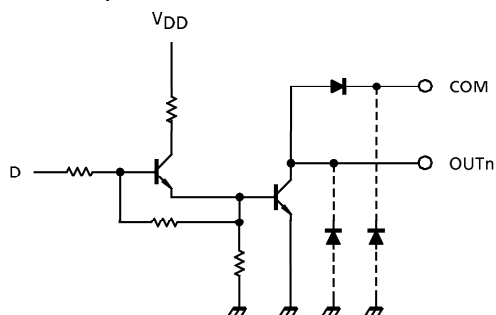
$\overline{\text{ENABLE}}$ terminal equivalent circuits



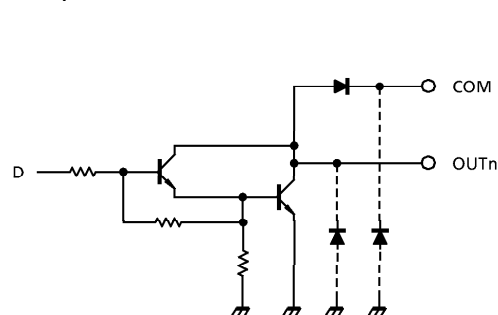
S-OUT terminal equivalent circuits



Output terminal equivalent circuits
(TD62C851P)



Output terminal equivalent circuits
(TD62C852P)



(Note) The output parasitic diode cannot be used as clamp diode.

TRUTH TABLE

CK	$\bar{E}$	$\bar{R}$	$\bar{LATCH}$	S-IN	OUT		S-OUT
					$\overline{O1}$	$\overline{O_n-1}$	
	L	H	H	L	OFF	$\overline{O_n-1}$	Q ₇
	L	H	H	H	ON	$\overline{O_n-1}$	Q ₇
	L	H	L	(*)	NC	NC	Q ₇
	H	H	(*)	(*)	OFF	NC	Q ₇
	(*)	(*)	(*)	(*)	NC	NC	Q ₇
(*)	(*)	L	H	(*)	OFF	OFF	L
(*)	H		L	(*)	NC	NC	L
CK = CLOCK $\bar{E}$ = ENABLE $\bar{R}$ = RESET $\bar{LATCH}$ = LATCH S-IN = SERIAL IN OUT = PARALLEL OUT S-OUT = SERIAL OUT (*) = DON'T CARE NC = NO CHANGE L = LOW LEVEL H = HIGH LEVEL							

MAXIMUM RATINGS (Ta = 25°C)

CHARACTERISTIC		SYMBOL	RATING	UNIT
Supply Voltage		V _{DD}	- 0.3~7.0	V
Output Sustaining Voltage		V _{CE (SUS)}	- 0.5~50	V
Output Current	TD62C851P	I _{OUT}	200	mA / ch
	TD62C852P		500	
Input Voltage		V _{IN}	~0.4~V _{DD} + 0.3	V
Power Dissipation		P _D	1.47	W
Operating Temperature		T _{opr}	- 40~85	°C
Storage Temperature		T _{stg}	- 55~150	°C

RECOMMENDED OPERATING CONDITIONS (Ta = -40~85°C)

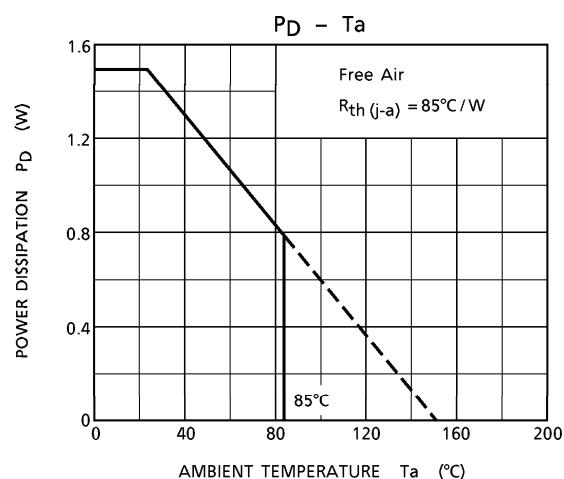
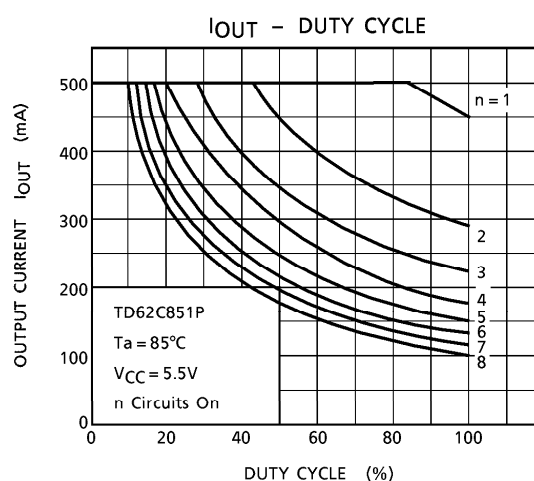
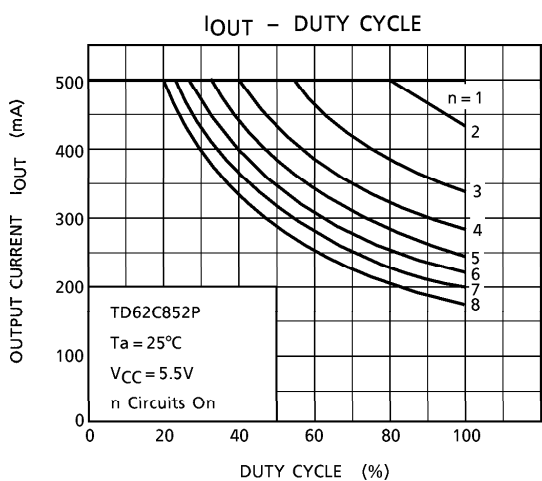
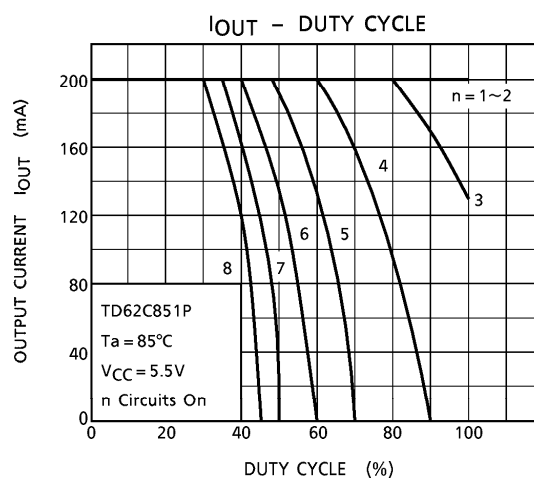
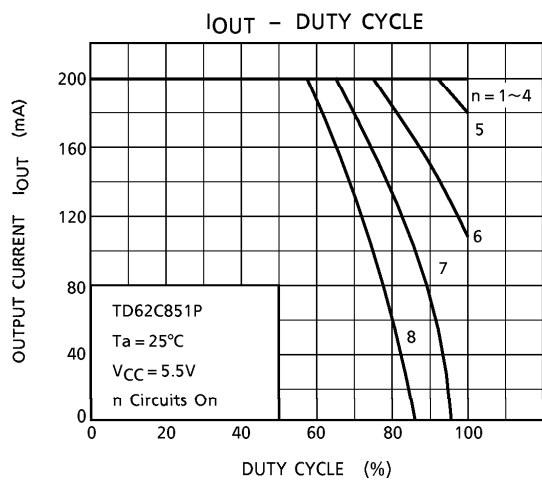
CHARACTERISTIC		SYMBOL	CONDITION		MIN.	TYP.	MAX.	UNIT
Supply Voltage		V _{DD}	—		4.5	5.0	5.5	V
Input Voltage		V _{IN}	—		0	—	V _{DD}	V
Output Current ("H" Level)	S-OUT	I _{OH}	Ta = 25°C		—	—	− 0.4	mA
Output Voltage ("L" Level)	$\overline{\text{On}}$	V _{OH}	—		0	—	50	V
Output Current ("L" Level)	S-OUT	I _{OL}	—		—	—	0.4	mA / ch
	TD62C851P		DC 1 circuit, Ta = 25°C		0	—	160	
			8 circuit on T _{pw} = 25ms Ta = 85°C V _{DD} = 5.5V	Duty = 10%	0	—	160	
				Duty = 40%	0	—	95	
			TD62C852P	DC 1 circuit, Ta = 25°C		0	—	
	8 circuit on T _{pw} = 25ms Ta = 85°C V _{DD} = 5.5V			Duty = 10%	0	—	400	
			Duty = 50%	0	—	170		
	Clock Frequency		f _{CLOCK}	—		1.5	—	
Clock Pulse Width		f _w CLOCK	—		0.33	—	—	μs
Data Set Up Time		t _{setup}	—		100	—	—	ns
Data Hold Time		t _{hold}	—		100	—	—	ns
Clamp Diode Reverse Voltage		V _R	—		0	—	50	V
Clamp Diode Forward Current	TD62C851P	I _F	—		0	—	160	mA
	TD62C852P		—		0	—	400	

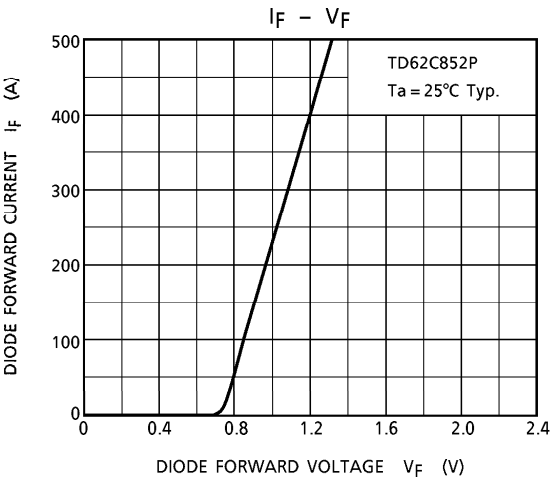
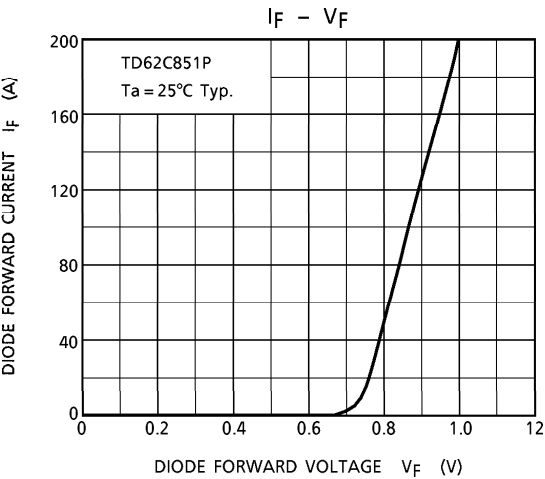
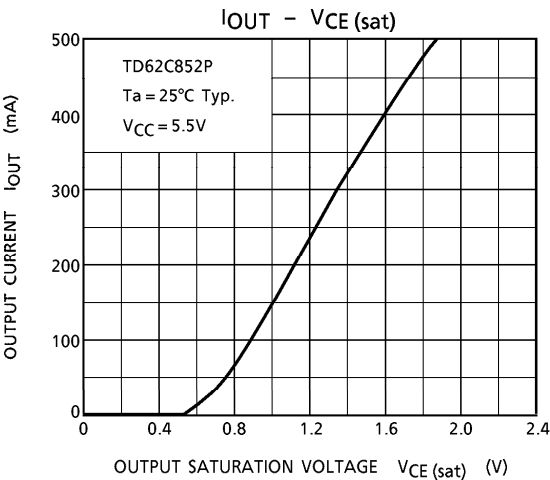
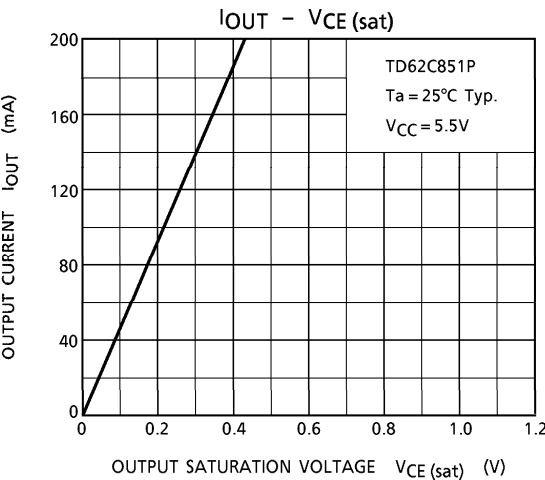
ELECTRICAL CHARACTERISTICS (Ta = -40~85°C)

CHARACTERISTIC			SYM- BOL	TEST CIR- CUIT	TEST CONDITION		MIN.	TYP.	MAX.	UNIT	
Input Voltage		"H" Level	V _{IH}	—	—		0.7 V _{DD}	—	—	V	
		"L" Level	V _{IL}	—	—		—	—	0.3 V _{DD}		
Input Current		"H" Level	I _{IH}	—	ENABLE, V _{DD} = 5.5V V _{IH} = V _{DD}		28	55	110	μA	
		"L" Level	I _{IL}	—	LATCH, RESET V _{DD} = 5.5V, V _{IL} = GND		− 55	− 110	− 275		
			I _{IN}	—	CLOCK, S-IN V _{IN} = V _{CC} or GND		—	—	± 1.0		
Output Voltage	"H" Level	S-OUT		V _{OH}	—	V _{DD} = 4.5V I _{OH} = − 10 μA		3.9	4.1	—	V
	"L" Level	S-OUT		V _{OL}	—	V _{DD} = 4.5V	I _{OL} = 0.8mA	—	0.2	0.4	V
		$\overline{\text{On}}$	TD62C 851P				I _{OL} = 100mA	—	0.29	0.50	
			TD62C 852P				I _{OL} = 160mA	—	0.39	0.65	
							I _{OL} = 250mA	—	1.24	1.90	
							I _{OL} = 400mA	—	1.54	2.30	
Output Current	"H" Level	$\overline{\text{On}}$		I _{OH}	—	V _{DD} = 5.5V, V _{OH} = 50.0V		—	—	100	μA
Operating Supply Current			I _{DD1}	—	V _{DD} = 5.5V Ta = 25°C	ENABLE = "H"	—	130	200	mA	
			I _{DD2}			f _{CLK} = 1MHz Output open DATA = 1 / 2 f _{CLK}	—	2.0	5.0		
			TD62C851P			I _{DD3}	1 circuit on f _{CLK} = 1MHz ENABLE = "L"	—	35		40
							TD62C851P	—	1.0		1.5
Clamp Diode Reverse Current			I _R	—	V _R = 50V		—	—	50	μA	
Clamp Diode Forward Voltage		TD62C851P	V _F	—	I _F = 160mA		—	1.0	2.0	V	
		TD62C852P			I _F = 400mA		—	1.5	2.0		

SWITCHING CHARACTERISTICS (Ta = 25°C)

CHARACTERISTIC			SYMBOL	TEST CIRCUIT	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Propagation Delay Time	Low-to-High	CK-S-OUT	t _{pLH}	—	V _{DD} = 5.0V, V _{IH} = 5.0V V _{IL} = 0V, Duty = 50% R _L = $\left[\begin{array}{l} 300\Omega \text{ (TD62C851P)} \\ 120\Omega \text{ (TD62C852P)} \end{array} \right]$	—	0.40	0.65	μs
		CK-On				—	1.80	3.00	
		L-On				—	2.10	3.50	
		R-On				—	1.50	2.50	
		E-On				—	1.50	2.50	
	High-to-Low	CK-S-OUT	t _{pHL}	—		—	0.33	0.55	
		CK-On				—	0.41	0.70	
		L-On				—	0.30	0.50	
		R-S-OUT				—	0.25	0.42	
		E-On				—	0.21	0.35	
Maximum Clock Frequency			f _{MAX}	—		1.5	2.0	—	MHz
Minimum Pulse Width		CLOCK	t _{wCK}	—		—	250	330	ns
		LATCH	t _{wL}			—	116	160	
		RESET	t _{wR}			—	107	140	
Data Set Up Time			t _{setup}	—		—	30	60	ns
Data Hold Time			t _{hold}		—	14	40		
Maximum Clock Rise Time			t _r		—	—	70	—	ns
Maximum Clock Fall Time			t _f	—		70	—		



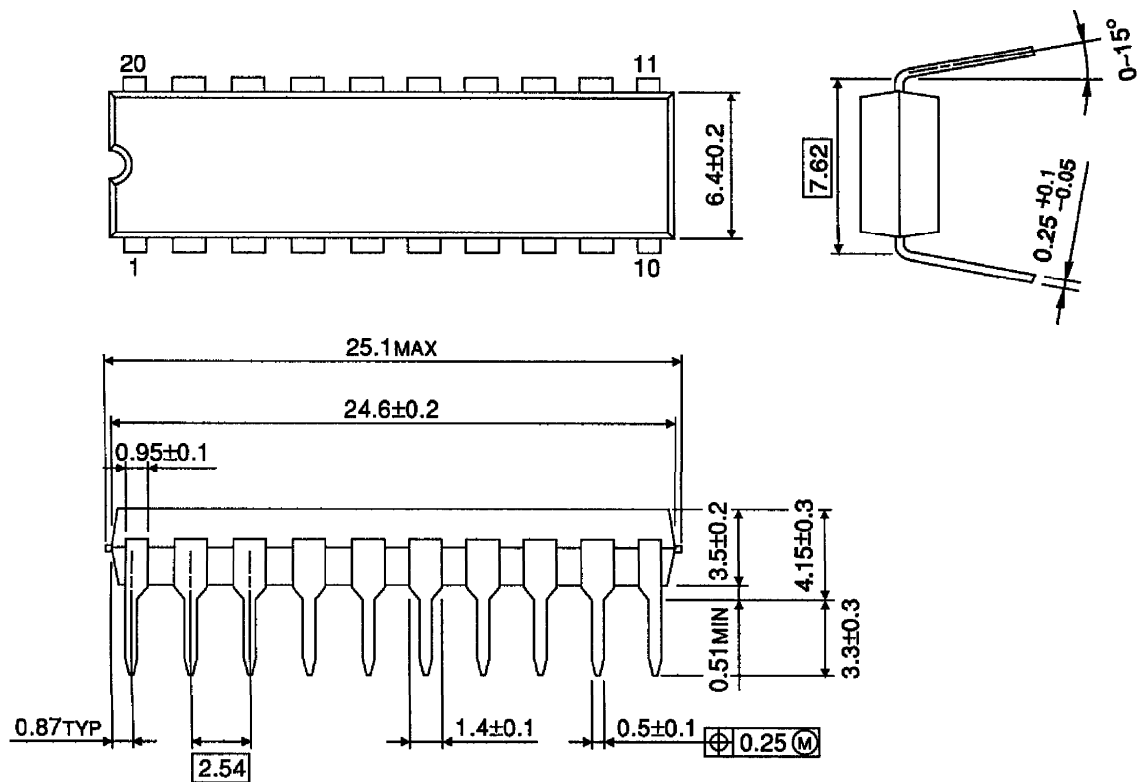


PRECAUTIONS for USING

Utmost care is necessary in the design of the output line, V_{CC} and GND line since IC may be destroyed due to short-circuit between outputs, air contamination fault, or fault by improper grounding.

OUTLINE DRAWING
DIP20-P-300-2.54A

Unit : mm



Weight : 2.25g (Typ.)